

High Transient-Thermal-Shock Resistant Nanochannel Tungsten Films

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Supporting Figures

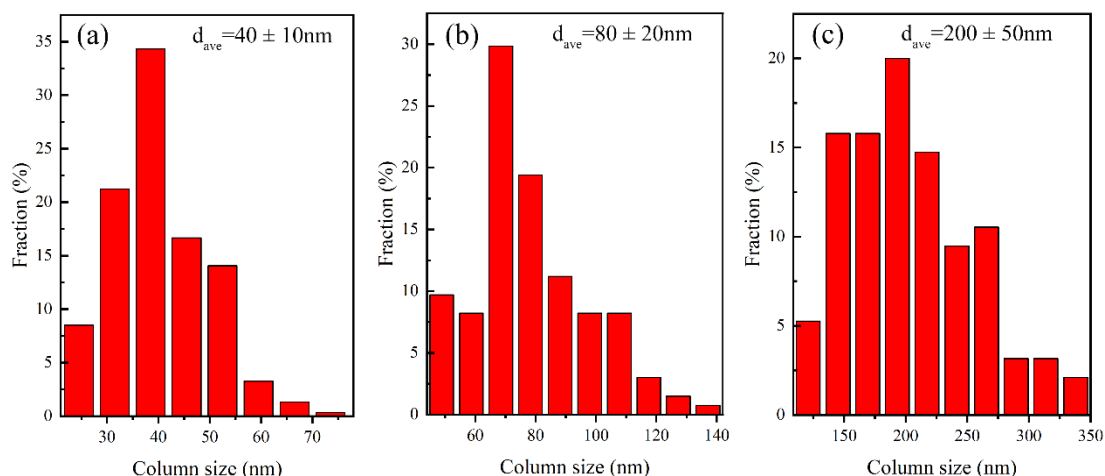


Figure S1. Statistical results of the average column size of nanochannel films W-150W-1 (a), W-50W-1 (b), W-150W-10 (c), respectively.

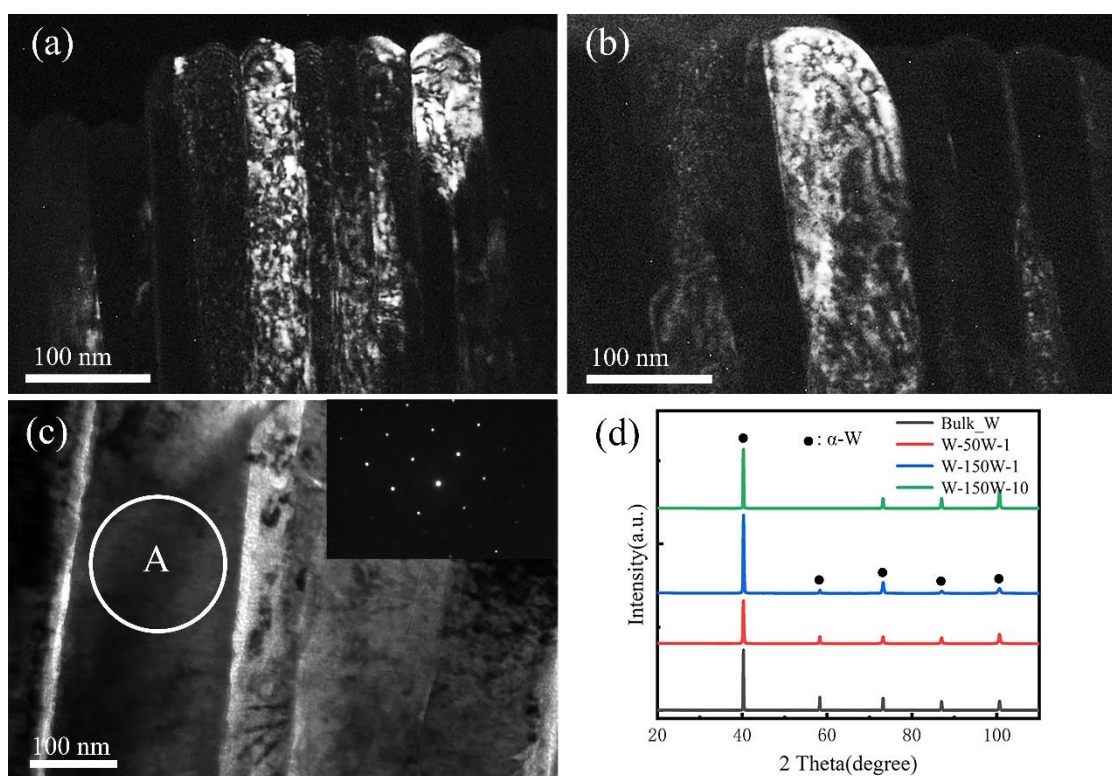


Figure S2. The dark-field XTEM image of the W-150W-1 (a) and W-50W-1 (b) film; The bright-field XTEM images of the W-150W-10 film (c), insert show the electron diffraction in region A; (d) is the corresponding GIXRD image.

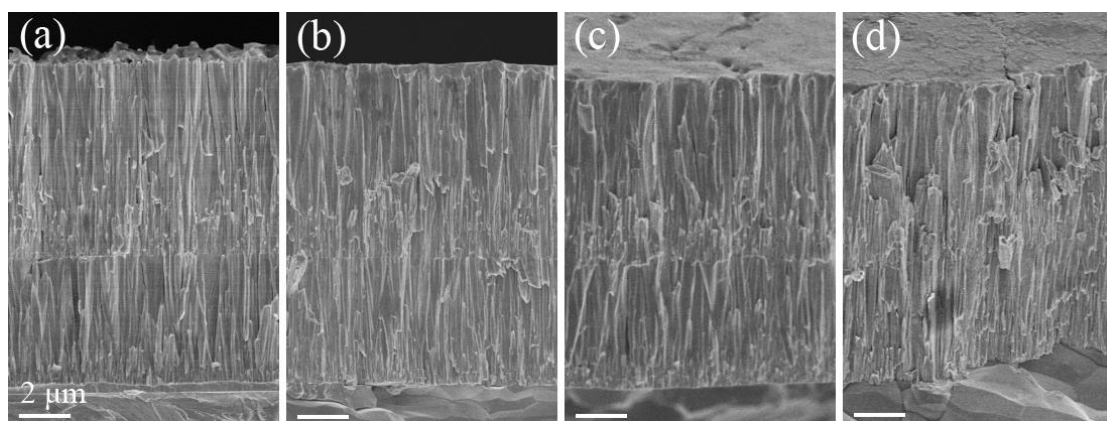


Figure S3. The SEM images of the W-150W-10 film irradiated by HIPIB with the energy density of 1 J/cm² and the pulses of 0 (a), 10 (b), 50 (c) and 100 (d), respectively. The corresponding scale is uniform.

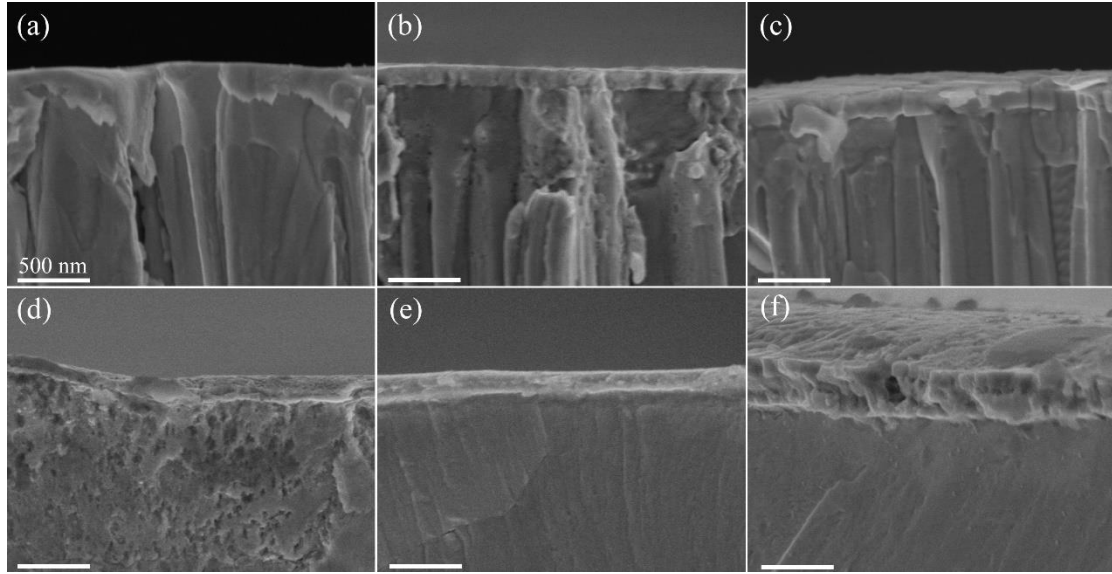


Figure S4. The SEM images of the W-150W-10 film and bulk W irradiated by HIPIB; (a), (b) and (c) are the irradiated W-150W-10 film and (d), (e) and (f) are the irradiated bulk W with the energy density of 1 J/cm² and the pulses of 10, 50 and 100, respectively. The corresponding scale is uniform.

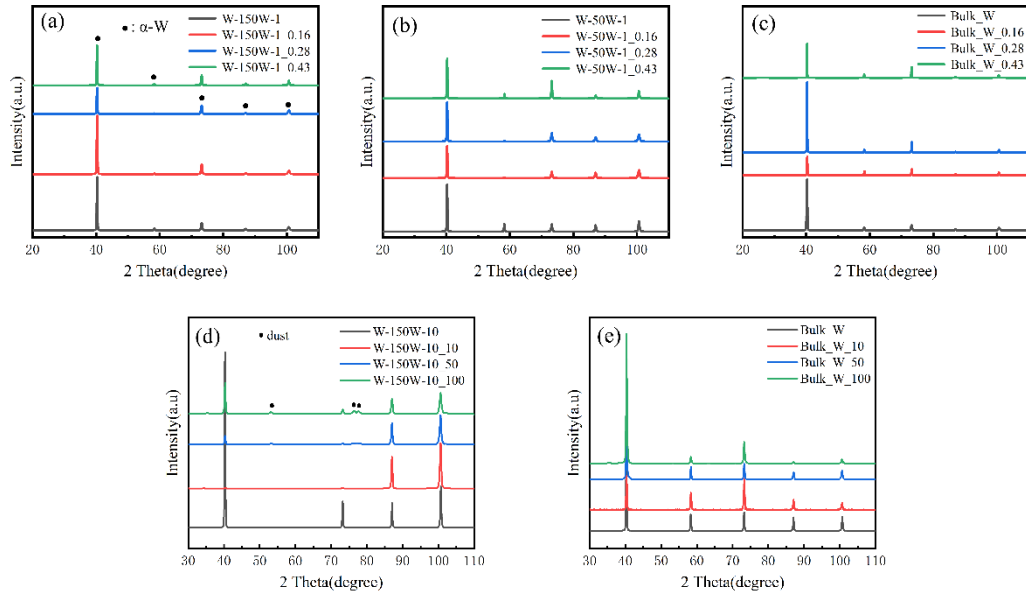


Figure S5. The GIXRD patterns of all samples. The W-150W-1 (a), W-50W-1 (b) films, and bulk W (c) irradiated by pulsed electron beam with the absorbed power density of 0.16, 0.28 and 0.43 GW/m², respectively; the W-150W-10 film (d) and the bulk W (e) irradiated by HIPIB with the energy density of 1 J/cm², respectively. All samples are performed with an angle of incidence $\alpha = 5^\circ$.